spatstat Quick Reference 1.6-1

Type demo(spatstat) for an overall demonstration.

Creation, manipulation and plotting of point patterns

An object of class "ppp" describes a point pattern. If the points have marks, these are included as a component vector marks.

To create a point pattern:

ppp create a point pattern from (x,y) and window information ppp(x, y, xlim, ylim) for rectangular window ppp(x, y, poly) for polygonal window ppp(x, y, mask) for binary image window convert other types of data to a ppp object setmarks %mark% attach/reassign marks to a point pattern

To simulate a random point pattern:

runifpoint generate n independent uniform random points generate n independent random points rpoint generate n independent multitype random points rmpoint simulate the (in)homogeneous Poisson point process rpoispp rmpoispp simulate the (in)homogeneous multitype Poisson point process rMaternI simulate the Matérn Model I inhibition process simulate the Matérn Model II inhibition process rMaternII simulate Simple Sequential Inhibition process rSSI simulate a general Neyman-Scott process rNeymanScott rMatClustsimulate the Matérn Cluster process simulate the Thomas process rThomas rmh simulate Gibbs point process using Metropolis-Hastings

Standard point pattern datasets:

Remember to say data(bramblecanes) etc.

amacrine Austin Hughes' rabbit amacrine cells betacells Wässle et al. cat retinal ganglia data

bramble canes Bramble Canes data

cells Crick-Ripley biological cells data

copper Berman-Huntington copper deposits data

demopat Synthetic point pattern finpines Finnish Pines data

hamster Aherne's hamster tumour data

japanesepines Japanese Pines data lansing Lansing Woods data longleaf Longleaf Pines data

nztrees Mark-Esler-Ripley trees data

redwood Strauss-Ripley redwood saplings data redwoodfull Strauss redwood saplings data (full set)

simdat Simulated point pattern (inhomogeneous, with interaction)

spruces Spruce trees in Saxonia

swedishpines Strand-Ripley swedish pines data

To manipulate a point pattern:

plot.ppp plot a point pattern

plot(X)

"[.ppp" extract or replace a

subset of a point pattern

pp[subset]

pp[, subwindow]

superimpose superimpose any number of point patterns cut.ppp discretise the marks in a point pattern

unmark remove marks

setmarks attach marks or reset marks split.ppp divide pattern into sub-patterns

rotate rotate pattern shift translate pattern

affine apply affine transformation

ksmooth.ppp kernel smoothing

identify.ppp interactively identify points

See spatstat.options to control plotting behaviour.

To create a window:

An object of class "owin" describes a spatial region (a window of observation).

owin Create a window object

owin(xlim, ylim) for rectangular window

owin(poly) for polygonal window
owin(mask) for binary image window
Convert other data to a window object

ripras Ripley-Rasson estimator of window, given only the points

letterR polygonal window in the shape of the R logo

To manipulate a window:

as.owin

plot.owin plot a window.

plot(W)

bounding.box Find a tight bounding box for the window

erode.owin erode window by a distance r complement.owin invert (inside \leftrightarrow outside)

rotate rotate window shift translate window

affine apply affine transformation

Digital approximations:

as.mask Make a discrete pixel approximation of a given window

nearest.raster.point map continuous coordinates to raster locations

raster.x raster x coordinates raster.y raster y coordinates

See spatstat.options to control the approximation

Geometrical computations with windows:

intersect.owin intersection of two windows

union.owin union of two windows

inside.owin determine whether a point is inside a window

area.owin compute window's area

diameter compute window frame's diameter eroded.areas compute areas of eroded windows

bdist.points compute distances from data points to window boundary bdist.pixels compute distances from all pixels to window boundary

distance transform image

centroid.owin compute centroid (centre of mass) of window is.subset.owin determine whether one window contains another

trim.owin intersect a window with a rectangle

Pixel images

An object of class "im" represents a pixel image. Such objects are returned by some of the functions in spatstat including Kmeasure, setcov and ksmooth.ppp.

im create a pixel image

as.im convert other data to a pixel image

plot.im plot a pixel image on screen as a digital image

contour.im draw contours of a pixel image

persp.im draw perspective plot of a pixel image

[.im extract subset of pixel image shift.im apply vector shift to pixel image

X print very basic information about image X

summary(X) summary of image X

is.im test whether an object is a pixel image

Exploratory Data Analysis

Inspection of data

```
summary(X) print useful summary of point pattern XX print basic description of point pattern X
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Quadrat methods

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quadratcount Quadrat counts
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Summary statistics for a point pattern:

Fest empty space function F

Gest nearest neighbour distribution function G

Kest Ripley's K-function

Jest J-function J = (1 - G)/(1 - F) all stats all four functions F, G, J, K

pcf pair correlation function

envelope simulation envelopes for K, G etc Kinhom K for inhomogeneous point patterns

 ${\tt Kest.fft}$ fast K-function using FFT for large datasets

Kmeasure reduced second moment measure nndist nearest neighbour distances

pairdist distances between all pairs of points crossdist distances between points in two patterns

exactdt distance from any location to nearest data point

distance map image

Summary statistics for a multitype point pattern:

A multitype point pattern is represented by an object X of class "ppp" with a component X\$marks which is a factor.

Gcross, Gdot, Gmulti multitype nearest neighbour distributions G_{ii} , $G_{i\bullet}$

Kcross, Kdot, Kmulti multitype K-functions $K_{ij}, K_{i\bullet}$ Jcross, Jdot, Jmulti multitype J-functions $J_{ij}, J_{i\bullet}$

all types estimates of the above for all i, j pairs

Summary statistics for a marked point pattern:

A marked point pattern is represented by an object X of class "ppp" with a component X\$marks.

markcorr mark correlation function

Gmulti multitype nearest neighbour distribution

Kmulti multitype K-function multitype J-function

Alternatively use cut.ppp to convert a marked point pattern to a multitype point pattern.

Programming tools

applynbd apply function to every neighbourhood in a point pattern

Model Fitting

To fit a point process model:

Model fitting in spatstat version 1.6 is performed by the function ppm. Its result is an object of class ppm.

ppm Fit a point process model to a two-dimensional point pattern

Manipulating the fitted model:

plot.ppm Plot the fitted model
predict.ppm Compute the spatial trend
and conditional intensity

of the fitted point process model Extract the fitted model coefficients

coef.ppm Extract the fitted model coefficients

fitted.ppm Compute fitted conditional intensity at quadrature points

update.ppm Update the fit

rmh.ppm Simulate from fitted model

print.ppm Print basic information about a fitted model

summary.ppm Summarise a fitted model anova.ppm Analysis of deviance

See spatstat.options to control plotting of fitted model.

To specify a point process model:

The first order "trend" of the model is written as an S language formula.

~1 No trend (stationary)

 \tilde{x} First order term $\lambda(x, y) = \exp(\alpha + \beta x)$ where x, y are Cartesian coordinates

polynom(x,y,3) Log-cubic polynomial trend
harmonic(x,y,2) Log-harmonic polynomial trend

The higher order ("interaction") components are described by an object of class interact. Such objects are created by:

Poisson() the Poisson point process

Strauss() the Strauss process

StraussHard() the Strauss/hard core point process
Softcore() pairwise interaction, soft core potential
PairPiece() pairwise interaction, piecewise constant

DiggleGratton() Diggle-Gratton potential LennardJones() Lennard-Jones potential

Pairwise() pairwise interaction, user-supplied potential

Geyer's saturation process

Saturated pair model, user-supplied potential

OrdThresh() Ord process, threshold potential Ord() Ord model, user-supplied potential

MultiStrauss() multitype Strauss process

MultiStraussHard() multitype Strauss/hard core process

Finer control over model fitting:

A quadrature scheme is represented by an object of class "quad".

quadscheme generate a Berman-Turner quadrature scheme

for use by ppm

default.dummydefault pattern of dummy pointsgridcentresdummy points in a rectangular gridstratrandstratified random dummy patternspokesradial pattern of dummy points

corners dummy points at corners of the window quadrature weights by the grid-counting rule dirichlet.weights quadrature weights are Dirichlet tile areas

print (Q) print basic information about quadrature scheme Q

summary (Q) summary of quadrature scheme Q

Simulation and goodness-of-fit

rmh.ppm simulate realisations of a fitted model

envelope compute simulation envelopes for a fitted model

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